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Attachment materials for electronic assembly –

Part 1-2: Requirements for soldering pastes for high-quality interconnects in electronics assembly

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

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ATTACHMENT MATERIALS FOR ELECTRONIC ASSEMBLY –

Part 1-2: Requirements for soldering pastes for high-quality interconnects in electronics assembly

FOREWORD

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International Standard IEC 61190-1-2 has been prepared by IEC technical committee 91: Electronics assembly technology.

This second edition cancels and replaces the first edition, published in 2002, and constitutes a technical revision. The main changes with regard to the first edition concern a definition of lead-free solder alloy and an explanation of solder ball test standards.

The text of this standard is based on the following documents:

FDIS	Report on voting
91/646/FDIS	91/678/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 61190 series, under the general title *Attachment materials for electronic assembly*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed;
- withdrawn;
- replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date.

INTRODUCTION

This part of IEC 61190 defines the characteristics of solder paste through the definitions of properties and specification of test methods and inspection criteria. Materials include solder powder and solder paste flux blended to produce solder paste. Solder powders are classified according to both shape and size distribution of the particles. It is not the intention of this standard to exclude those particle sizes or distributions not specifically listed. For flux properties of solder paste, including classification and testing, see IEC 61190-1-1.

The requirements for solder paste are defined in general terms. In practice, where more stringent requirements are necessary, additional requirements may be defined by mutual agreement between the user and supplier. Users are cautioned to perform tests (beyond the scope of this specification) to determine the acceptability of the solder paste for specific processes.

This standard is intended to be applicable to all types of solder paste used for soldering in general, as well as for soldering in electronics assembly. The solder pastes involved relate to all aspects of application. Generic specifications for soldering pastes are given in ISO 9454-2.

ATTACHMENT MATERIALS FOR ELECTRONIC ASSEMBLY –

Part 1-2: Requirements for soldering pastes for high-quality interconnects in electronics assembly

1 Scope

This part of IEC 61190 specifies general requirements for the characterization and testing of solder pastes used to make high-quality electronic interconnections in electronics assembly. This standard serves as a quality control document and is not intended to relate directly to the material's performance in the manufacturing process.

Related information on flux characterization, quality control and procurement documentation for solder flux and flux containing material may be found in IEC 61190-1-1.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60194, *Printed board design, manufacture and assembly – Terms and definitions*

IEC 61189-5, *Test methods for electrical materials, interconnection structures and assemblies – Part 5: Test methods for printed board assemblies*

IEC 61189-6, *Test methods for electrical materials, interconnection structures and assemblies – Part 6: Test methods for materials used in manufacturing electronic assemblies*

IEC 61190-1-1, *Attachment materials for electronic assembly – Part 1-1: Requirements for soldering fluxes for high quality interconnections in electronics assembly*

IEC 61190-1-3, *Attachment materials for electronic assembly – Part 1-3: Requirements for electronic grade solder alloys and fluxed and non-fluxed solid solders for electronic soldering applications*

IEC 61191-1, *Printed board assemblies – Part 1: Generic specification – Requirements for soldered electrical and electronic assemblies using surface mount and related assembly technologies*

IEC 61191-2, *Printed board assemblies – Part 2: Sectional specification – Requirements for surface mount soldered assemblies*

IEC 61191-3, *Printed board assemblies – Part 3: Sectional specification – Requirements for through-hole mount soldered assemblies*

IEC 61191-4, *Printed board assemblies – Part 4: Sectional specification – Requirements for terminal soldered assemblies*

ISO 9000, *Quality management systems – Fundamentals and vocabulary*

ISO 9001, *Quality management systems – Requirements*

ISO 9453, *Soft solder alloys – Chemical compositions and forms*

ISO 9454-2, *Soft soldering fluxes – Classification and requirements – Part 2: Performance requirements*

ISO 10012-1, *Quality assurance requirements for measuring equipment – Part 1: Metrological confirmation system for measuring equipment*